

<b>Notice of References Cited</b>	Application/Control No. 09/785,573	Applicant(s)/Patent Under Reexamination CREETH, RICHARD F.	
	Examiner Chongshan Chen	Art Unit 2162	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,535,872	03-2003	Castelli et al.	707/3
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	M	US-			

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**NON-PATENT DOCUMENTS**

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	V	Data Warehousing and OLAP, A Research-Oriented bibliography, <a href="http://www.ondelette.com/OLAP/dwbib.html">http://www.ondelette.com/OLAP/dwbib.html</a>
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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